

Search Notes



Application/Control No.

10/605,160

Examiner

Rodney G. McDonald

Applicant(s)/Patent under
Reexamination

CHIU, WEN-PIN

Art Unit

1753

SEARCHED

Class	Subclass	Date	Examiner
204	192.12	6/7/07	me
1	192.17		
	192.15		
	192.3		
	298.06		
204	298.11	6/7/07	me

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
noe	6/7/07	me